Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
09/823,581	CHEN ET AL.
Examiner	Art Unit

3623

Scott L. Jarrett

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
705	9	3/27/2007	SJ	
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East - EP, JP, US see attached search history	3/27/2007	, sì
ProQuest see attached search history	3/27/2007	' SJ
AU 3623 Allowance Panel see attached search history	3/27/2007	, si
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